

# **BAS116T**

# Single low leakage current switching diode Rev. 2 — 9 July 2012

Product data sheet

#### 1. **Product profile**

#### 1.1 General description

Single low leakage current switching diode, encapsulated in an ultra small SOT416 (SC-75) Surface-Mounted Device (SMD) plastic package.

#### 1.2 Features and benefits

- High switching speed: t<sub>rr</sub> = 0.8 μs
- Low leakage current: 3 pA
- Repetitive peak reverse voltage:  $V_{RRM} \le 85 \text{ V}$
- AEC-Q101 qualified

- Low capacitance: C<sub>d</sub> = 2 pF
- Reverse voltage: V<sub>R</sub> ≤ 75 V
- Ultra small SMD plastic package

#### 1.3 Applications

- Low leakage current applications
- General-purpose switching
- Voltage clamping
- Reverse polarity protection

#### 1.4 Quick reference data

Table 1. Quick reference data

| Symbol          | Parameter             | Conditions   | Min          | Тур | Max | Unit |
|-----------------|-----------------------|--------------|--------------|-----|-----|------|
| I <sub>F</sub>  | forward current       |              | <u>[1]</u> _ | -   | 215 | mA   |
| I <sub>R</sub>  | reverse current       | $V_R = 75 V$ | -            | -   | 5   | nA   |
| $V_R$           | reverse voltage       |              | -            | -   | 75  | V    |
| t <sub>rr</sub> | reverse recovery time |              | [2] _        | -   | 3   | μS   |

<sup>[1]</sup> Pulse test:  $t_p \le 300~\mu s;~\delta \le 0.02.$ 

#### **Pinning information** 2.

Table 2 Pinning

| Table 2. | i iiiiiiig    |                    |                |
|----------|---------------|--------------------|----------------|
| Pin      | Description   | Simplified outline | Graphic symbol |
| 1        | anode         |                    |                |
| 2        | not connected | 3                  | 3              |
| 3        | cathode       |                    | 1 2            |
|          |               | 1                  | 006aaa764      |
|          |               |                    |                |



<sup>[2]</sup> When switched from  $I_F = 10$  mA to  $I_R = 10$  mA;  $R_L = 100$   $\Omega$ ; measured at  $I_R = 1$  mA.

#### Single low leakage current switching diode

## 3. Ordering information

Table 3. Ordering information

| Type number | Package |                                          |         |  |  |
|-------------|---------|------------------------------------------|---------|--|--|
|             | Name    | Description                              | Version |  |  |
| BAS116T     | SC-75   | plastic surface-mounted package; 3 leads | SOT416  |  |  |

## 4. Marking

Table 4. Marking codes

| Type number | Marking code |
|-------------|--------------|
| BAS116T     | ZY           |

## 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol           | Parameter                           | Conditions                  | Min        | Max  | Unit |
|------------------|-------------------------------------|-----------------------------|------------|------|------|
| $V_{RRM}$        | repetitive peak reverse voltage     |                             | -          | 85   | V    |
| $V_R$            | reverse voltage                     |                             | -          | 75   | V    |
| I <sub>F</sub>   | forward current                     |                             | [1] -      | 215  | mA   |
| I <sub>FRM</sub> | repetitive peak forward current     |                             | -          | 500  | mA   |
| I <sub>FSM</sub> | non-repetitive peak forward current | square wave                 | <u>[2]</u> |      |      |
|                  |                                     | $t_p = 1 \mu s$             | -          | 4    | Α    |
|                  |                                     | $t_p = 1 \text{ ms}$        | -          | 1    | Α    |
|                  |                                     | t <sub>p</sub> = 1 s        | -          | 0.5  | Α    |
| P <sub>tot</sub> | total power dissipation             | $T_{amb} \le 25  ^{\circ}C$ | [3] _      | 150  | mW   |
| Tj               | junction temperature                |                             | -          | 150  | °C   |
| T <sub>amb</sub> | ambient temperature                 |                             | -55        | +150 | °C   |
| T <sub>stg</sub> | storage temperature                 |                             | -65        | +150 | °C   |

<sup>[1]</sup> Pulse test:  $t_p \leq 300~\mu s;~\delta \leq 0.02.$ 

<sup>[2]</sup>  $T_i = 25$  °C before surge.

<sup>[3]</sup> Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

#### Single low leakage current switching diode

### 6. Thermal characteristics

Table 6. Thermal characteristics

| Symbol         | Parameter                                        | Conditions  | Min          | Тур | Max | Unit |
|----------------|--------------------------------------------------|-------------|--------------|-----|-----|------|
| $R_{th(j-a)}$  | thermal resistance from junction to ambient      | in free air | <u>[1]</u> - | -   | 833 | K/W  |
| $R_{th(j-sp)}$ | thermal resistance from junction to solder point |             | <u>[2]</u> - | -   | 350 | K/W  |

<sup>[1]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

## 7. Characteristics

 Table 7.
 Characteristics

 $T_{amb} = 25$  °C unless otherwise specified.

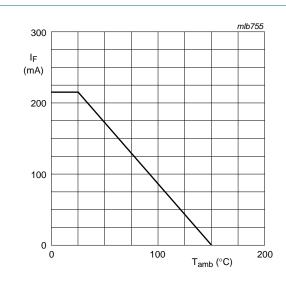
| Symbol          | Parameter             | Conditions                                       |     | Min | Тур   | Max  | Unit |
|-----------------|-----------------------|--------------------------------------------------|-----|-----|-------|------|------|
| $V_{F}$         | forward voltage       |                                                  | [1] |     |       |      |      |
|                 |                       | I <sub>F</sub> = 1 mA                            |     | -   | -     | 0.9  | V    |
|                 |                       | I <sub>F</sub> = 10 mA                           |     | -   | -     | 1    | V    |
|                 |                       | $I_F = 50 \text{ mA}$                            |     | -   | -     | 1.1  | V    |
|                 |                       | I <sub>F</sub> = 150 mA                          |     | -   | -     | 1.25 | V    |
| I <sub>R</sub>  | reverse current       | V <sub>R</sub> = 75 V                            |     | -   | 0.003 | 5    | nA   |
|                 |                       | $V_R = 75 \text{ V}; T_j = 150 ^{\circ}\text{C}$ |     | -   | 3     | 80   | nA   |
| t <sub>rr</sub> | reverse recovery time |                                                  | [2] | -   | 8.0   | 3    | μS   |
| C <sub>d</sub>  | diode capacitance     | $V_R = 0 V$ ; $f = 1 MHz$                        |     | -   | 2     | -    | pF   |

<sup>[1]</sup> Pulse test:  $t_p \le 300~\mu s;~\delta \le 0.02.$ 

<sup>[2]</sup> Soldering point of cathode tab.

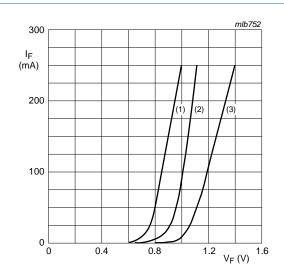
<sup>[2]</sup> When switched from  $I_F$  = 10 mA to  $I_R$  = 10 mA;  $R_L$  = 100  $\Omega;$  measured at  $I_R$  = 1 mA.

#### Single low leakage current switching diode



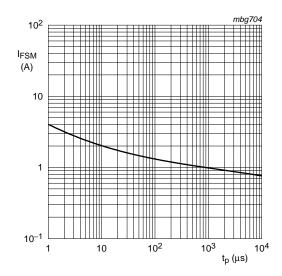
FR4 PCB, standard footprint

Fig 1. Forward current as a function of ambient temperature; derating curve



- (1)  $T_{amb} = 150 \,^{\circ}\text{C}$ ; typical values
- (2)  $T_{amb} = 25 \,^{\circ}C$ ; typical values
- (3)  $T_{amb} = 25 \, ^{\circ}C$ ; maximum values

Fig 2. Forward current as a function of forward voltage

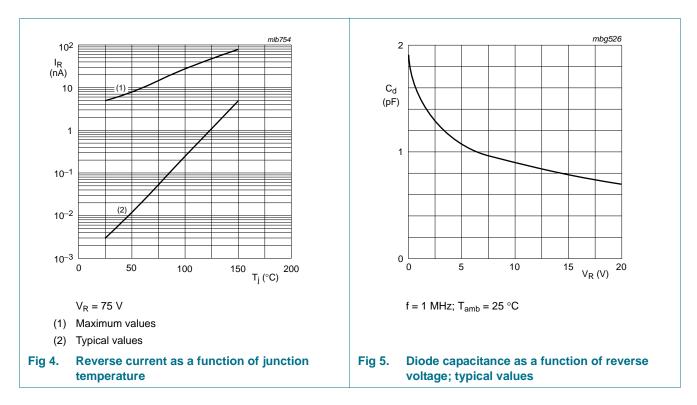


Based on square wave currents.

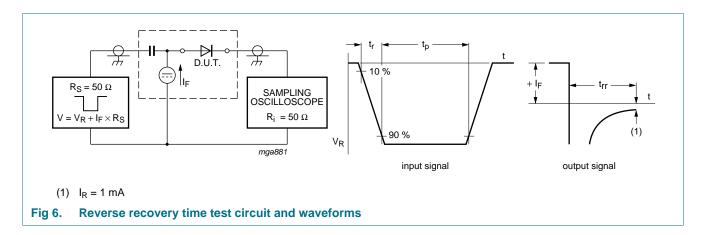
 $T_j = 25$  °C before surge

Fig 3. Non-repetitive peak forward current as a function of pulse duration; maximum values

#### Single low leakage current switching diode



### 8. Test information

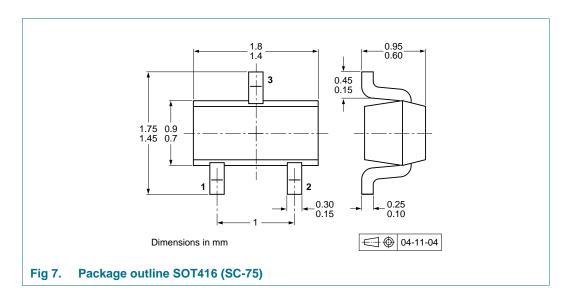


### 8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101 - Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

#### Single low leakage current switching diode

## 9. Package outline



## 10. Packing information

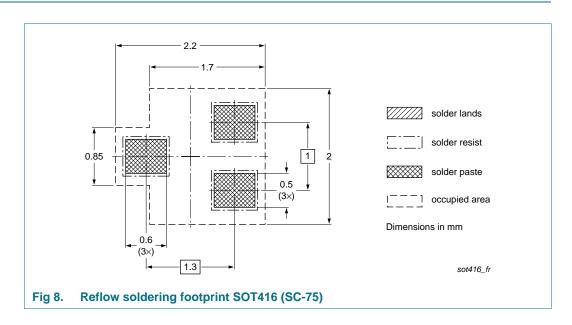
Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

| Type number | Package | Description                    | Packing quantity |       |
|-------------|---------|--------------------------------|------------------|-------|
|             |         |                                | 3000             | 10000 |
| BAS116T     | SOT416  | 4 mm pitch, 8 mm tape and reel | -115             | -135  |

<sup>[1]</sup> For further information and the availability of packing methods, see Section 14.

## 11. Soldering



BAS1167

## Single low leakage current switching diode

## 12. Revision history

#### Table 9. Revision history

| Document ID    | Release date  | Data sheet status                                                                          | Change notice | Supersedes  |
|----------------|---------------|--------------------------------------------------------------------------------------------|---------------|-------------|
| BAS116T v.2    | 20120709      | Product data sheet                                                                         | -             | BAS116T v.1 |
| Modifications: | • Section 8.1 | Pinning information": correc<br>"Quality information": adde<br>(Legal information": update | ed            |             |
| BAS116T v.1    | 20091214      | Product data sheet                                                                         | -             | -           |

#### Single low leakage current switching diode

## 13. Legal information

#### 13.1 Data sheet status

| Document status[1][2]          | Product status[3] | Definition                                                                            |
|--------------------------------|-------------------|---------------------------------------------------------------------------------------|
| Objective [short] data sheet   | Development       | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification     | This document contains data from the preliminary specification.                       |
| Product [short] data sheet     | Production        | This document contains the product specification.                                     |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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